Product data sheet

Product profile

1.1 General description

Planar passivated sensitive gate four quadrant triac in a SOT54 (TO-92) plastic package intended for use in applications requiring enhanced noise immunity and direct interfacing to logic ICs and low power gate drivers.

1.2 Features and benefits

- Direct interfacing to logic level ICs
- Enhanced current surge capability
- Enhanced noise immunity
- High blocking voltage capability
- Sensitive gate triggering in all four quadrants

1.3 Applications

- General purpose low power motor control
- Home appliances

- Industrial process control
- Low power AC Fan controllers

1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V_{DRM}	repetitive peak off-state voltage		-	-	600	V
I _{TSM}	non-repetitive peak on-state current	full sine wave; $T_{j(init)} = 25 ^{\circ}C$; $t_p = 20 \text{ms}$; see Figure 4; see Figure 5	-	-	12.5	Α
I _{T(RMS)}	RMS on-state current	full sine wave; T _{lead} ≤ 38 °C; see <u>Figure 3</u> ; see <u>Figure 1</u> ; see <u>Figure 2</u>	-	-	1	Α
Static chara	acteristics					
l _{GT}	gate trigger current	$V_D = 12 \text{ V; } I_T = 0.1 \text{ A; } T2+G+;$ $T_j = 25 \text{ °C; see } \frac{\text{Figure 7}}{}$	0.2	-	3	mA
		$V_D = 12 \text{ V; } I_T = 0.1 \text{ A; } T2 + G-;$ $T_j = 25 \text{ °C; see } \frac{\text{Figure 7}}{\text{Figure 7}}$	0.2	-	3	mA
		$V_D = 12 \text{ V; } I_T = 0.1 \text{ A; } T2\text{- G-;}$ $T_j = 25 \text{ °C; see } \frac{\text{Figure 7}}{}$	0.2	-	3	mA
		$V_D = 12 \text{ V; } I_T = 0.1 \text{ A; T2- G+;}$ $T_j = 25 \text{ °C; see } \frac{\text{Figure 7}}{\text{Figure 7}}$	0.2	-	5	mA



4Q Triac

2. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	T2	main terminal 2		N I
2	G	gate		T2 — T1
	T1	main terminal 1		sym051
			SOT54 (TO-92)	

3. Ordering information

Table 3. Ordering information

Type number Package			
	Name	Description	Version
Z0103MA0	TO-92	plastic single-ended leaded (through hole) package; 3 leads	SOT54

4. Limiting values

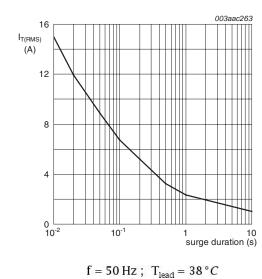
Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{DRM}	repetitive peak off-state voltage		-	600	V
I _{T(RMS)}	RMS on-state current	full sine wave; $T_{lead} \le 38$ °C; see Figure 3; see Figure 1; see Figure 2	-	1	Α
I _{TSM}	non-repetitive peak on-state current	full sine wave; $T_{j(init)} = 25 ^{\circ}\text{C}$; $t_p = 20 \text{ms}$; see <u>Figure 4</u> ; see <u>Figure 5</u>	-	12.5	Α
		full sine wave; $T_{j(init)} = 25 \text{ °C}$; $t_p = 16.7 \text{ ms}$	-	13.8	Α
I ² t	I ² t for fusing	t _p = 10 ms; sine-wave pulse	-	0.78	A ² s
dl _T /dt	rate of rise of on-state current	I_T = 1 A; I_G = 20 mA; dI_G/dt = 100 mA/ μ s; T2+ G+	-	50	A/µs
		I_T = 1 A; I_G = 20 mA; dI_G/dt = 100 mA/ μ s; T2+ G-	-	50	A/µs
		I_T = 1 A; I_G = 20 mA; dI_G/dt = 100 mA/ μ s; T2- G-	-	50	A/µs
		I_T = 1 A; I_G = 20 mA; dI_G/dt = 100 mA/ μ s; T2- G+	-	20	A/µs
I _{GM}	peak gate current		-	1	Α
P_{GM}	peak gate power		-	2	W
$P_{G(AV)}$	average gate power	over any 20 ms period	-	0.1	W
T _{stg}	storage temperature		-40	150	°C
Tj	junction temperature		-	125	°C

Z0103MA0

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1.2 I_{T(RMS)} 8.0 0.4 0 -50 100 T_{lead} (°C)

RMS on-state current as a function of surge duration; maximum values

RMS on-state current as a function of lead Fig 2. temperature; maximum values

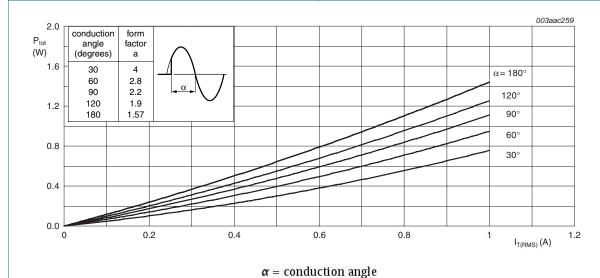


Fig 3. Total power dissipation as a function of RMS on-state current; maximum values

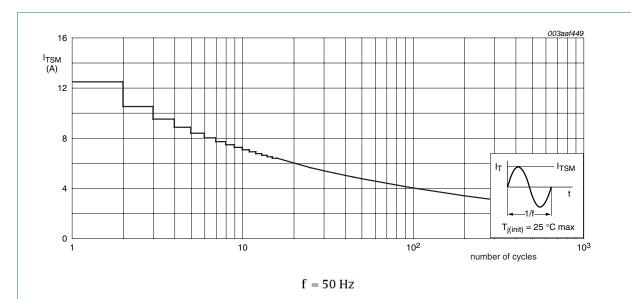


Fig 4. Non-repetitive peak on-state current as a function of the number of sinusoidal current cycles; maximum values

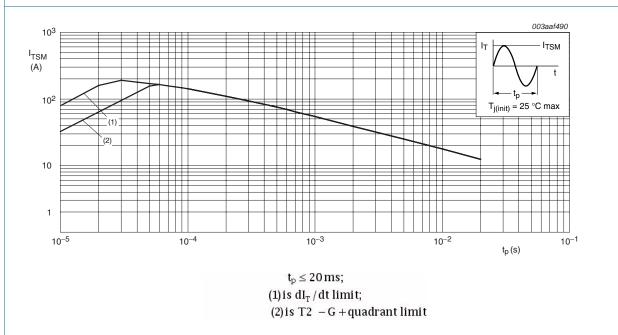


Fig 5. Non-repetitive peak on-state current as a function of pulse width; maximum values

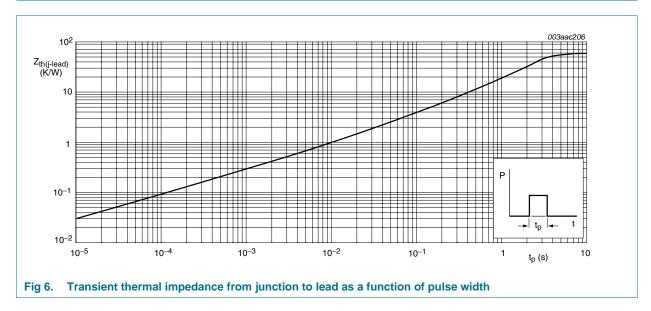
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4Q Triac

5. Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{\text{th(j-lead)}}$	thermal resistance from junction to lead	full cycle	-	-	60	K/W
R _{th(j-a)}	thermal resistance from junction to ambient	full cycle; printed-circuit board mounted; lead length 4 mm; see Figure 6	-	150	-	K/W



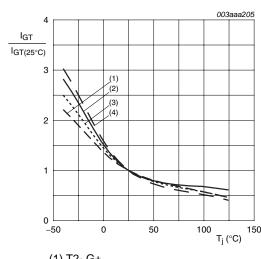
6. Characteristics

Table 6. Characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static char	acteristics					
I _{GT}	gate trigger current	$V_D = 12 \text{ V; } I_T = 0.1 \text{ A; } T2+G+; T_j = 25 \text{ °C;}$ see Figure 7	0.2	-	3	mA
		$V_D = 12 \text{ V}; I_T = 0.1 \text{ A}; T2+G-; T_j = 25 °C;$ see Figure 7	0.2	-	3	mA
		$V_D = 12 \text{ V}; I_T = 0.1 \text{ A}; T2- G-; T_j = 25 ^{\circ}\text{C};$ see Figure 7	0.2	-	3	mA
		$V_D = 12 \text{ V}; I_T = 0.1 \text{ A}; T2- G+; T_j = 25 ^{\circ}\text{C};$ see Figure 7	0.2	-	5	mA
I _L latching	latching current	$V_D = 12 \text{ V}; I_G = 0.1 \text{ A}; T2+ G+;$ $T_j = 25 \text{ °C}; \text{ see } \frac{\text{Figure 8}}{\text{Figure 8}}$	-	-	7	mA
		$V_D = 12 \text{ V; } I_G = 0.1 \text{ A; } T2+G-; T_j = 25 \text{ °C;}$ see <u>Figure 8</u>	-	-	20	mA
		$V_D = 12 \text{ V}; I_G = 0.1 \text{ A}; \text{ T2- G-}; T_j = 25 \text{ °C};$ see Figure 8	-	-	7	mA
		$V_D = 12 \text{ V}; I_G = 0.1 \text{ A}; T2-G+; T_j = 25 °C;$ see <u>Figure 8</u>	-	-	7	mA
I _H	holding current	$V_D = 12 \text{ V; } T_j = 25 \text{ °C; see } \frac{\text{Figure } 12}{}$	-	-	7	mA
V _T	on-state voltage	$I_T = 1 \text{ A}$; $T_j = 25 \text{ °C}$; see Figure 9	-	1.3	1.6	V
V_{GT}	gate trigger voltage	$V_D = 12 \text{ V; } I_T = 0.1 \text{ A; } T_j = 25 \text{ °C;}$ see Figure 10	-	-	1.3	V
		$V_D = 600 \text{ V}; I_T = 0.1 \text{ A}; T_j = 125 ^{\circ}\text{C}$	0.2	-	-	V
I _D	off-state current	V _D = 600 V; T _j = 125 °C	-	-	0.5	mΑ
Dynamic o	haracteristics					
dV _D /dt	rate of rise of off-state voltage	V _{DM} = 402 V; T _j = 110 °C; gate open circuit; exponential waveform; see Figure 11	80	-	-	V/µs
dV _{com} /dt	rate of change of commutating voltage	V_D = 400 V; T_j = 110 °C; dI_{com}/dt = 0.44 A/ms; gate open circuit	0.5	-	-	V/µs

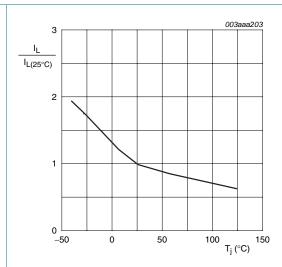
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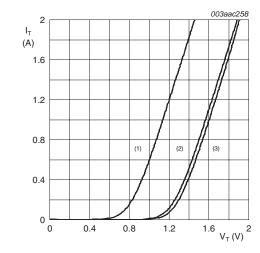


- (1) T2- G+
- (2) T2- G-
- (3) T2+ G-
- (4) T2+ G+

Normalized gate trigger current as a function of Fig 7. junction temperature



Normalized latching current as a function of Fig 8. junction temperature



 $V_0 = 1.254 \text{ V}$

 $R_s = 0.31 \Omega$

(1) T_j = 125 °C; typical values

(2) $T_j = 125$ °C; maximum values

(3) T_i = 25 °C; maximum values

Fig 9. On-state current as a function of on-state voltage

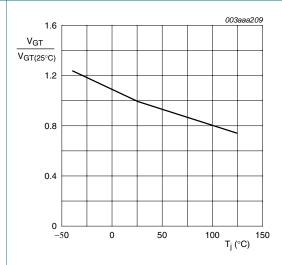


Fig 10. Normalized gate trigger voltage as a function of junction temperature

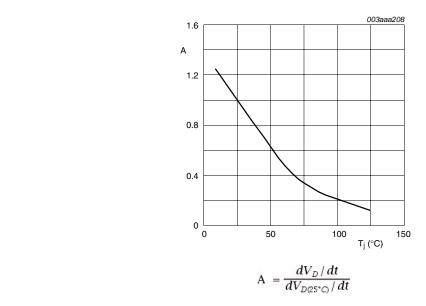


Fig 11. Normalized critical rate of rise of off-state voltage as a function of junction temperature; typical values

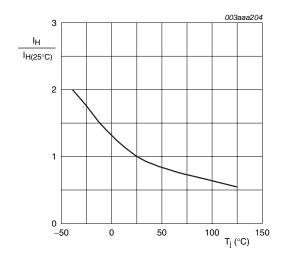


Fig 12. Normalized holding current as a function of junction temperature

7. Package outline

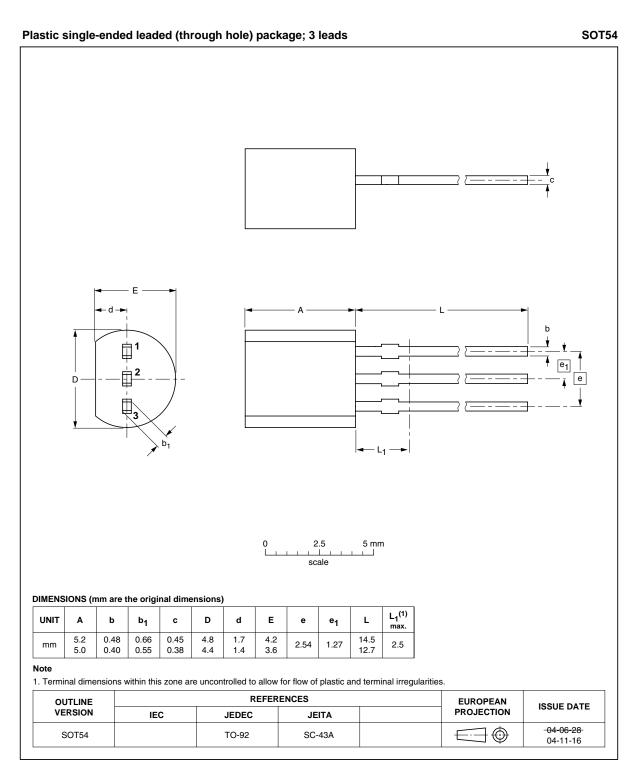


Fig 13. Package outline SOT54 (TO-92)

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8. Revision history

Table 7. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
Z0103MA0 v.1	20110103	Product data sheet	-	-

4Q Triac

9. Legal information

9.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
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4Q Triac

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NXP Semiconductors Z0103MA0
4Q Triac

11. Contents

1	Product profile
1.1	General description
1.2	Features and benefits
1.3	Applications
1.4	Quick reference data
2	Pinning information
3	Ordering information
4	Limiting values
5	Thermal characteristics
6	Characteristics
7	Package outline
8	Revision history10
9	Legal information1
9.1	Data sheet status
9.2	Definitions1
9.3	Disclaimers
9.4	Trademarks12
10	Contact information

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